



MJE13007-M

NPN SILICON TRANSISTOR

NPN BIPOLAR POWER TRANSISTOR FOR SWITCHING POWER SUPPLY APPLICATIONS

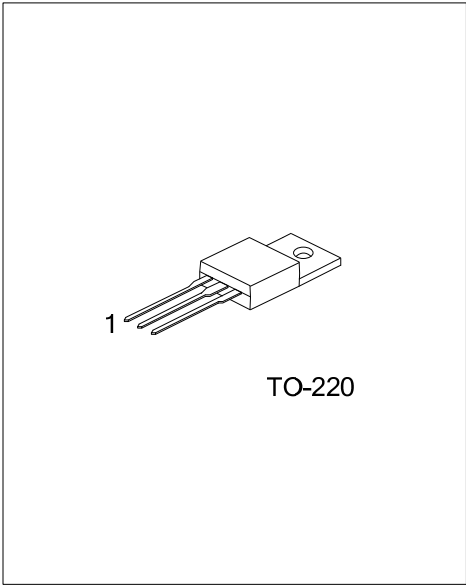
DESCRIPTION

The UTC **MJE13007-M** is designed for high-voltage and high-speed power switching inductive circuits where fall time is critical. It is particularly suited for 115 and 220 V switch mode applications.

FEATURES

- * $V_{CEO(SUS)}$ 400V
- * 700V Blocking Capability

ORDERING INFORMATION



| Ordering Number | | Package | Pin Assignment | | | Packing |
|-------------------|-------------------|---------|----------------|---|---|---------|
| Lead Free | Halogen Free | | 1 | 2 | 3 | |
| MJE13007L-M-TA3-T | MJE13007G-M-TA3-T | TO-220 | B | C | E | Tube |

| | |
|--|---|
| <p>MJE13007L-M-TA3-T</p> <p>(1)Packing Type (2)Package Type (3)Lead Free</p> | <p>(1)T: Tube (2) TA3: TO-220 (3) G: Halogen Free, L: Lead Free</p> |
|--|---|

■ ABSOLUTE MAXIMUM RATING

| PARAMETER | | SYMBOL | RATINGS | UNIT |
|--------------------------------------|--------------------------|-----------|----------|------------------|
| Collector-Emitter Sustaining Voltage | | V_{CEO} | 400 | V |
| Collector-Emitter Breakdown Voltage | | V_{CBO} | 700 | V |
| Emitter-Base Voltage | | V_{EBO} | 9.0 | V |
| Collector Current | Continuous | I_C | 8.0 | A |
| | Peak (1) | I_{CM} | 16 | A |
| Base Current | Continuous | I_B | 4.0 | A |
| | Peak (1) | I_{BM} | 8.0 | A |
| Emitter Current | Continuous | I_E | 12 | A |
| | Peak (1) | I_{EM} | 24 | A |
| Power Dissipation | $T_C = 25^\circ\text{C}$ | P_D | 80 | W |
| Junction Temperature | | T_J | +150 | $^\circ\text{C}$ |
| Storage Temperature | | T_{STG} | -55~+150 | $^\circ\text{C}$ |

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ THERMAL DATA

| PARAMETER | SYMBOL | RATINGS | UNIT |
|---------------------|---------------|---------|---------------------------|
| Junction to Ambient | θ_{JA} | 62.5 | $^\circ\text{C}/\text{W}$ |
| Junction to Case | θ_{JC} | 1.56 | $^\circ\text{C}/\text{W}$ |

Note 1: Pulse Test: Pulse Width = 5.0 ms, Duty Cycle $\leq 10\%$.

Measurement made with thermocouple contacting the bottom insulated mounting surface of the package (in a location beneath the die), the device mounted on a heatsink with thermal grease applied at a mounting torque of 6 to 8•lbs.

■ ELECTRICAL CHARACTERISTICS ($T_C=25^\circ\text{C}$, unless otherwise noted)

| PARAMETER | SYMBOL | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--------------------------------------|----------------|---|-----|-----|-----|---------------|
| Collector-Emitter Sustaining Voltage | $V_{CEO(SUS)}$ | $I_C=10\text{mA}, I_B=0$ | 400 | | | V |
| Collector Cutoff Current | I_{CBO} | $V_{CES}=700\text{V}$ | | | 0.1 | mA |
| | | $V_{CES}=700\text{V}, T_C=125^\circ\text{C}$ | | | 1.0 | mA |
| Emitter Cutoff Current | I_{EBO} | $V_{EB}=9.0\text{V}, I_C=0$ | | | 100 | μA |
| DC Current Gain | h_{FE1} | $I_C=2.0\text{A}, V_{CE}=5.0\text{V}$ | 8.0 | | 40 | |
| | h_{FE2} | $I_C=5.0\text{A}, V_{CE}=5.0\text{V}$ | 5.0 | | 30 | |
| Collector-Emitter Saturation Voltage | $V_{CE(SAT)}$ | $I_C=2.0\text{A}, I_B=0.4\text{A}$ | | | 1.0 | V |
| | | $I_C=5.0\text{A}, I_B=1.0\text{A}$ | | | 2.0 | |
| | | $I_C=5.0\text{A}, I_B=1.0\text{A}, T_C=100^\circ\text{C}$ | | | 3.0 | |
| | | $I_C=5.0\text{A}, I_B=2.5\text{A}$ | | | 0.6 | |
| | | $I_C=8.0\text{A}, I_B=2.0\text{A}$ | | | 3.0 | |
| Base-Emitter Saturation Voltage | $V_{BE(SAT)}$ | $I_C=2.0\text{A}, I_B=0.4\text{A}$ | | | 1.2 | V |
| | | $I_C=5.0\text{A}, I_B=1.0\text{A}$ | | | 1.6 | |
| | | $I_C=5.0\text{A}, I_B=1.0\text{A}, T_C=100^\circ\text{C}$ | | | 1.5 | |
| | | $I_C=5.0\text{A}, I_B=2.5\text{A}$ | | 1.2 | 1.5 | |
| | | | | | | |
| Current-Gain-Bandwidth Product | f_T | $I_C=500\text{mA}, V_{CE}=10\text{V}, f=1.0\text{MHz}$ | 4.0 | 14 | | MHz |
| Output Capacitance | C_{OB} | $V_{CB}=10\text{V}, I_E=0, f=0.1\text{MHz}$ | | 80 | | pF |

RESISTIVE LOAD (TABLE 1)

| | | | | | | |
|--------------|-------|---|--|-------|-----|---------------|
| Delay Time | t_D | $V_{CC}=125\text{V}, I_C=5.0\text{A}, I_{B1}=I_{B2}=1.0\text{A}, t_P=25\mu\text{s}, \text{Duty Cycle} \leq 1.0\%$ | | 0.025 | 0.1 | μs |
| Rise Time | t_R | | | 0.5 | 1.5 | μs |
| Storage Time | t_S | | | 1.8 | 3.0 | μs |
| Fall Time | t_F | | | 0.23 | 0.7 | μs |
| | | | | | | |

Note: Pulse Test: Pulse Width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2.0\%$

■ TYPICAL THERMAL RESPONSE

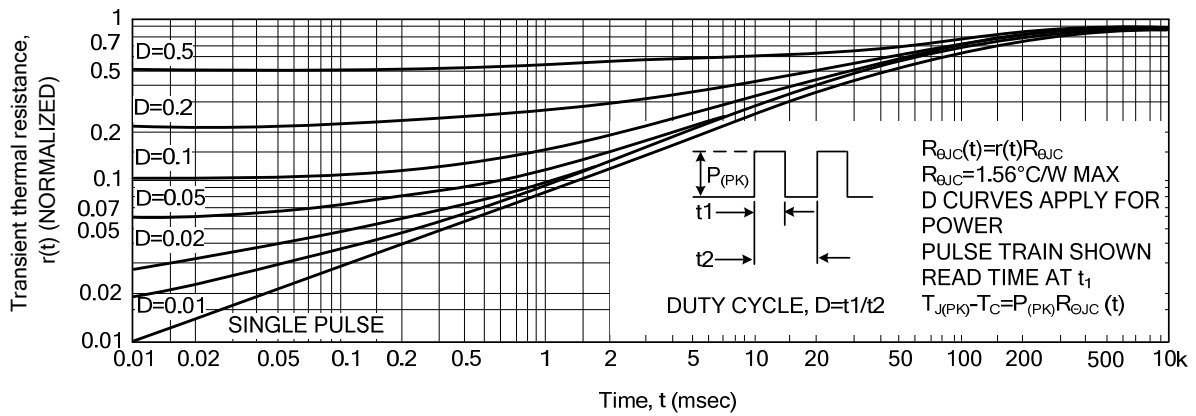


Fig. 1 Typical Thermal Response

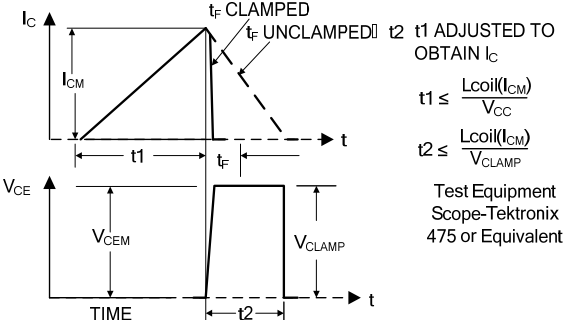
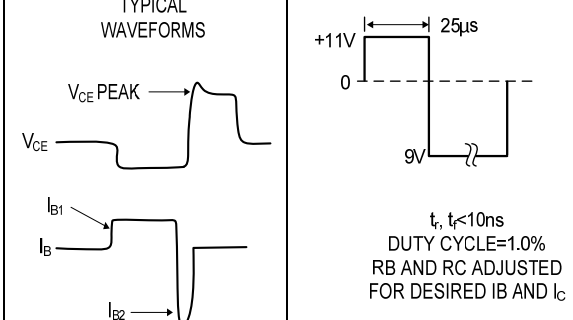
There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C - V_{CE} limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Fig. 7 is based on $T_C = 25^\circ\text{C}$; $T_{J(PK)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be debated when $T_C \geq 25^\circ\text{C}$. Second breakdown limitations do not debate the same as thermal limitations. Allowable current at the voltages shown on Fig. 7 may be found at any case temperature by using the appropriate curve on Fig. 9.

At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

Use of reverse biased safe operating area data (Fig. 8) is discussed in the applications information section.

Table 1. Test Conditions for Dynamic Performance

| TEST CIRCUITS | REVERSE BIAS SAFE OPERATING AREA AND INDUCTIVE SWITCHING | RESISTIVE SWITCHING | | | | | | |
|---|--|--|---------------------|-------|---|--|---|---|
| CIRCUIT VALUES | <table border="1" style="width: 100%; border-collapse: collapse;"> <thead> <tr> <th style="width: 33%;">BV_{CEO} (SUS)</th> <th style="width: 33%;">Inductive Switching</th> <th style="width: 33%;">RBSOA</th> </tr> </thead> <tbody> <tr> <td>L=10mH R_{B2}=8 V_{CC}=20V I_{C(PK)}=100mA</td> <td>L=20mH R_{B2}=0 V_{CC}=15V R_{B1} selected for desired I_{B1}</td> <td>L=500mH R_{B2}=0 V_{CC}=15Volts R_{B1} selected for desired I_{B1}</td> </tr> </tbody> </table> | BV _{CEO} (SUS) | Inductive Switching | RBSOA | L=10mH R _{B2} =8 V _{CC} =20V I _{C(PK)} =100mA | L=20mH R _{B2} =0 V _{CC} =15V R _{B1} selected for desired I _{B1} | L=500mH R _{B2} =0 V _{CC} =15Volts R _{B1} selected for desired I _{B1} | <p>V_{CC}=125V R_C=25Ω D1=1N5820 OR EQUIV</p> |
| BV _{CEO} (SUS) | Inductive Switching | RBSOA | | | | | | |
| L=10mH R _{B2} =8 V _{CC} =20V I _{C(PK)} =100mA | L=20mH R _{B2} =0 V _{CC} =15V R _{B1} selected for desired I _{B1} | L=500mH R _{B2} =0 V _{CC} =15Volts R _{B1} selected for desired I _{B1} | | | | | | |
| |  <p> $t_1 \leq \frac{L_{coil}(I_{CM})}{V_{CC}}$ $t_2 \leq \frac{L_{coil}(I_{CM})}{V_{CLAMP}}$ Test Equipment Scope-Tektronix 475 or Equivalent </p> | <p>TYPICAL WAVEFORMS</p>  <p> $t_r, t_f < 10ns$ DUTY CYCLE=1.0% RB AND RC ADJUSTED FOR DESIRED IB AND IC </p> | | | | | | |

TYPICAL CHARACTERISTICS

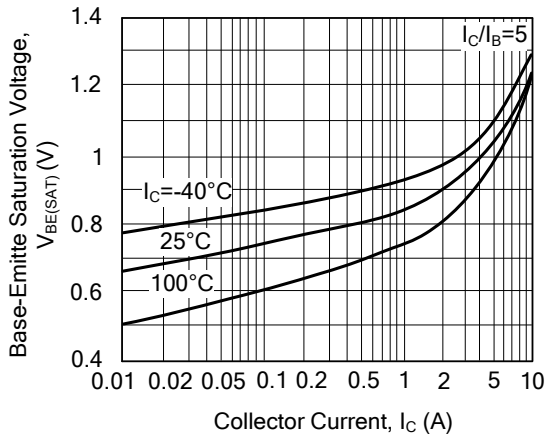


Fig. 2 Base-Emitter Saturation Voltage

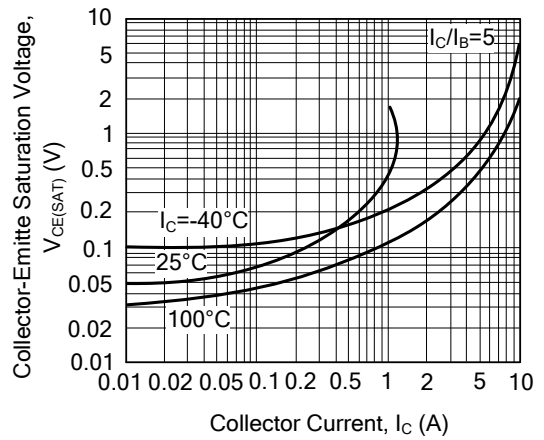


Fig. 3 Collector-Emitter Saturation Voltage

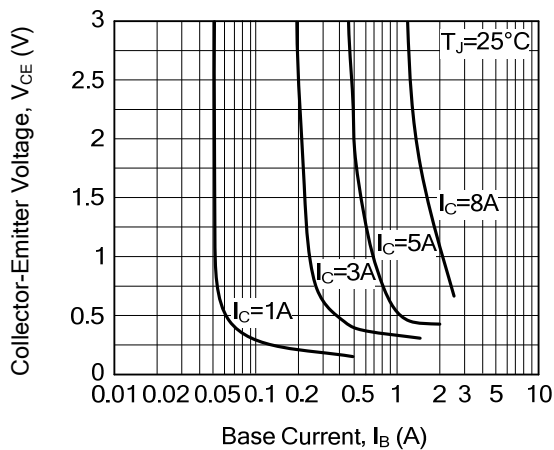


Fig. 4 Collector Saturation Region

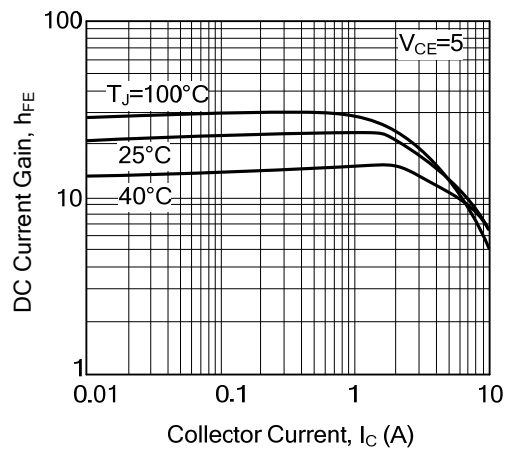


Fig. 5 DC Current Gain

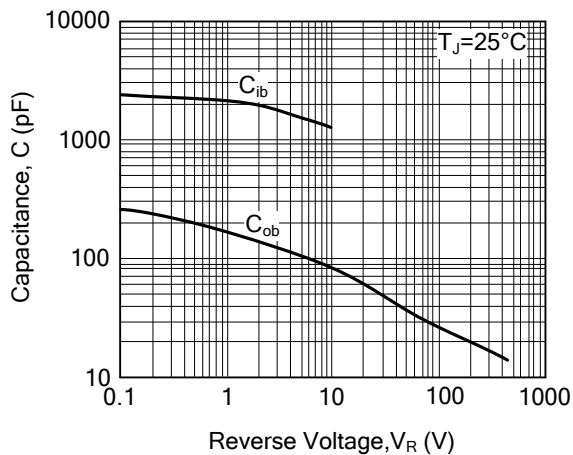


Fig. 6 Capacitance

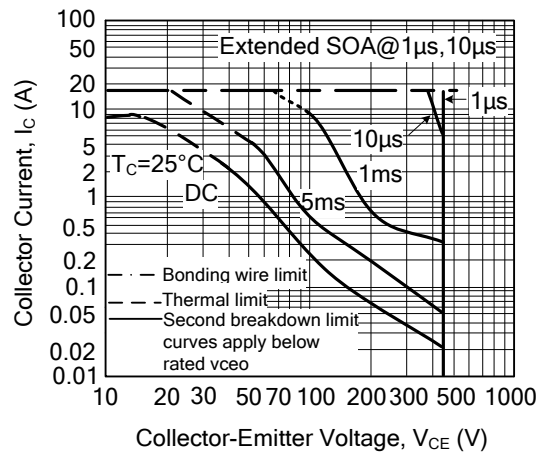


Fig. 7 Maximum Forward Bias Safe Operating Area

■ TYPICAL CHARACTERISTICS

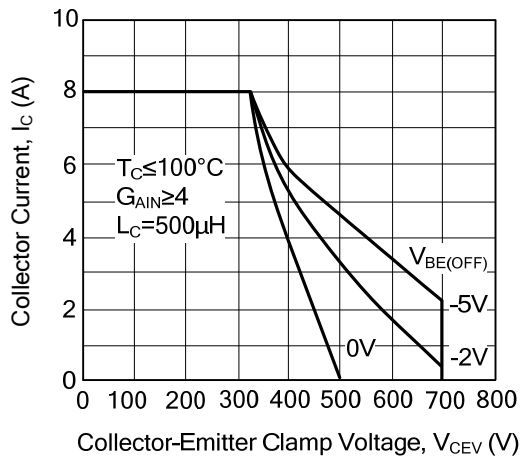


Fig. 8 Maximum Reverse Bias Switching Safe Operating Area

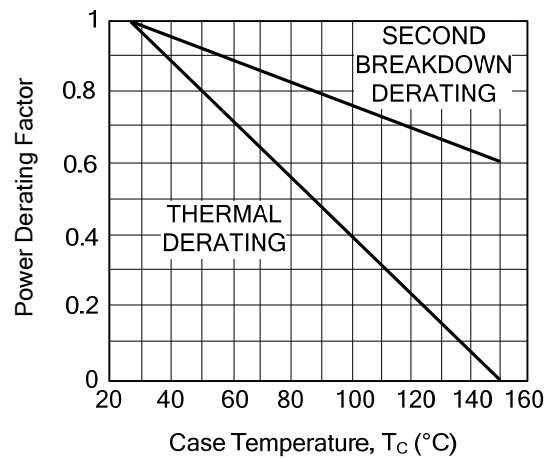


Fig. 9 Forward Bias Power Derating

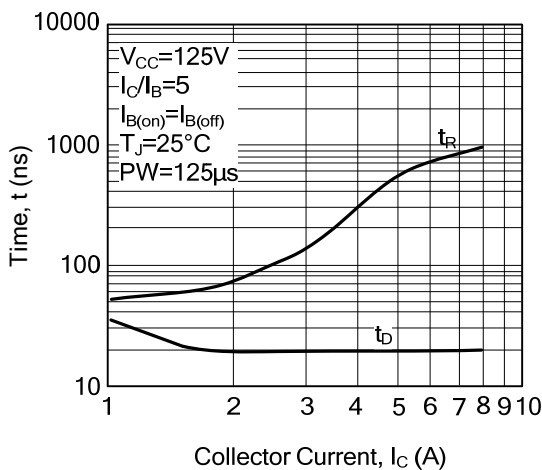


Fig. 10 Turn-On Time(Resistive Load)

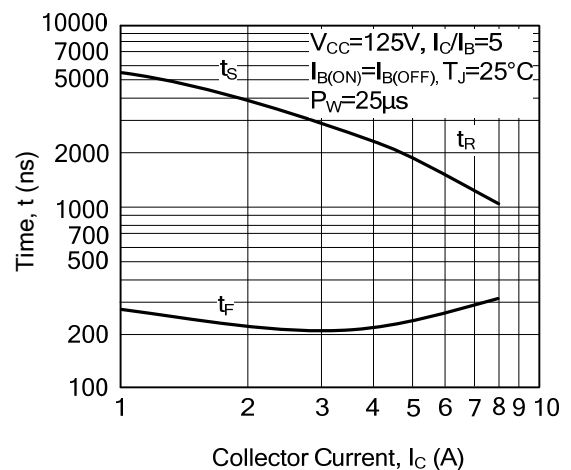


Fig. 11 Turn-Off Time(Resistive Load)

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